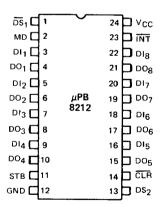
EIGHT-BIT INPUT/OUTPUT PORT

DESCRIPTION The μ PB8212 input/output port consists of an 8-bit latch with three-state output buffers along with control and device selection logic. Also included is a service request flip-flop for the control and generation of interrupts to the microprocessor.

> The device is multimode in nature and can be used to implement latches, gated buffers or multiplexers. Thus, all of the principal peripheral and input/output functions of a microcomputer system can be implemented with this device.

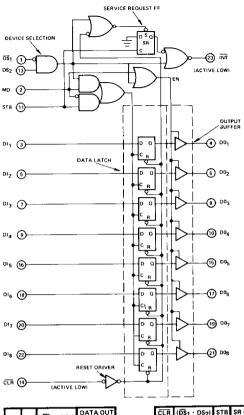
- FEATURES Fully Parallel 8-Bit Data Register and Buffer
 - · Service Request Flip-Flop for Interrupt Generation
 - Low Input Load Current 0.25 mA Max
 - Three State Outputs
 - Outputs Sink 15 mA
 - 3.65V Output High Voltage for Direct Interface to 8080A Processor
 - Asynchronous Register Clear
 - Replaces Buffers, Latches and Multiplexers in Microcomputer Systems
 - Reduces System Package Count
 - · Available in 24-pin Plastic and Cerdip Packages

PIN CONFIGURATION



PIN NAMES

| DI1 - DI8 | Data In |
|-----------------------------------|------------------------|
| DO ₁ - DO ₈ | Data Out |
| DS ₁ , DS ₂ | Device Select |
| MD | Mode |
| STB | Strobe |
| ĪNĪ | Interrupt (Active Low) |
| CLR | Clear (Active Low) |



| STB | MD | (DS1 · DS2) | DATA OUT EQUALS |
|-----|----|-------------|--------------------|
| 0 | 0 | 0 | Three-State |
| 1 | 0 | 0 | Three-State |
| 0 | 1 | 0 | Data Latch |
| 1 | 1 | 0 | Data Latch |
| 0 | 0 | 1 | Data Latch |
| 1 | 0 | 1 | Data In |
| 0 | 1 | 1 | Data In |
| 1 | 1 | 1 | Data In |

| CLR | (DS ₁ · DS ₂) | STB | SR ② | ĪNT |
|-----|--------------------------------------|------|------|-----|
| 0 | 0 | 0 | 1 | 1 |
| 0 | 1 | 0 | 1 | 0 |
| 1 | 0 | 0 | 3 | 0 |
| 1 | | 0 | 1 | 1 |
| 1 | 0 | | 0 | 0 |
| 1 | 1 | 0 | 1 | 0 |
| 1 | 1 | abla | 0 | 0 |

Notes: ① CLR resets data latch sets SR flip-flop. (No effect on output buffer)

- 2 Internal SR flip-flop
- ③ Previous data remains

| 0°C+0±70 | °C |
|-------------------------------|------------|
| Operating Temperature | , . |
| Storage Temperature | <i>,</i> , |
| All Output or Supply Voltages | olts |
| All Input Voltages | olts |
| Output Currents | nΑ |
| Output Currents | |

ABSOLUTE MAXIMUM RATINGS*

 $T_a = 25^{\circ}C$

*COMMENT: Stress above those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

DC CHARACTERISTICS T_a = 0°C to 70°C; VCC = +5V ± 5%

| PARAMETER | SYMBOL | LIMITS | | | |
|---|--------|--------|-------|------|------------------------------|
| PARAMETER | | MIN | MAX | UNIT | TEST CONDITIONS |
| Input Load Current STB, DS ₂ , CLR, DI ₁ – DI ₈ Inputs | IIL1 | | -0.25 | mA | V _F = 0.45V |
| Input Load Current MD Input | IIL2 | | -0.75 | mΑ | VF = 0.45V |
| Input Load Current DS ₁ Input | IIL3 | | -1.0 | mA | VF = 0.45V |
| Input Leakage Current STB DS, CLR, DI ₁ – DI ₈ Inputs | IIH1 | | 10 | μА | V _R = 5.25V |
| Input Leakage Current MD Input | tIH2 | | 30 | μΑ | V _R = 5.25V |
| Input Leakage Current DS ₁ Input | IIH3 | | 40 | μΑ | V _R = 5.25V |
| Input Forward Voltage Clamp | νc | | -1.0 | V | I _C = -5 mA |
| Input "Low" Voltage | VIL | | 0.85 | V | |
| Input "High" Voltage | VIH | 2.0 | | V | |
| Output "Low" Voltage | VOL | | 0.48 | V | IOL = 15 mA |
| Output "High" Voltage | ∨он | 3.65 | | V | IOH = -1 mA |
| Short Circuit Output Current | 105 | 15 | -75 | mA | VO = 0V VCC = 5V |
| Output Leakage Current High Impedance State DO ₀ – DO ₈ | 10 | | 20 | μА | V _O = 0.45V/5.25V |
| Power Supply Current | Icc | | 130 | mΑ | |
| | | | | | |

CAPACITANCE ① $T_a = 25^{\circ}C$; $V_{CC} = +5V$; $V_{BIAS} = 2.5V$; f = 1 MHz

| | | LIMITS | | | |
|--------------------|--------|--------|-----|------|-----------------------------------|
| PARAMETER | SYMBOL | MIN | MAX | UNIT | TEST CONDITIONS |
| Input Capacitance | CIN | | 12 | рF | DS ₁ , MD |
| Input Capacitance | CIN | | 9 | pF | DS2, CLR, STB, DI1 - DI8 |
| Output Capacitance | COUT | | 12 | pF | DO ₁ – DO ₈ |

Note: ① This parameter is periodically sampled and not 100% tested

AC CHARACTERISTICS $T_a = 0^{\circ} C \text{ to } +70^{\circ} C; V_{CC} = +5V \pm 5\%$

| PARAMETER | SYMBOL | LIMITS | | | |
|------------------------------|--------------------------------|--------|-----|------|--|
| | | MIN | MAX | UNII | TEST CONDITIONS |
| Pulse Width | tpw | 30 | | ns | Input Pulse |
| Data To Output Delay | t _{pd} | | 30 | ns | Amplitude = 2.5V |
| Write Enable To Output Delay | twe | | 40 | ns | Input Rise and Fall |
| Data Setup Time | t _{set} | 15 | | ns | Times = 5 ns Between 1V and 2V Measurement made at 1.5V with 15 mA |
| Data Hold Time | ^t h. | 20 | | ns | |
| Reset to Output Delay | t _r | | 40 | ns | |
| Set To Output Delay | ts | | 30 | ns | |
| Output Enable/Disable Time | t _e /t _d | | 45 | ns | and 30 pF Test Load |
| Clear To Output Delay | t _C | | 55 | ns | Test Load |

Notes: ① $R_1 = 300\Omega/10K\Omega$; $R_2 = 600\Omega/1K\Omega$

μPB8212

Data Latch

FUNCTIONAL DESCRIPTION

The 8 flip-flops that compose the data latch are of a "D" type design. The output (Q) of the flip-flop follows the data input (D) while the clock input (C) is high. Latching occurs when the clock (C) returns low.

The data latch is cleared by an asynchronous reset input (CLR).

(Note: Clock (C) Overrides Reset (CLR).)

Output Buffer

The outputs of the data latch (Q) are connected to three-state, non-inverting output buffers. These buffers have a common control line (EN); enabling the buffer to transmit the data from the outputs of the data latch (Q) or disabling the buffer, forcing the output into a high impedance state (three-state).

This high-impedance state allows the designer to connect the μ PB8212 directly to the microprocessor bi-directional data bus.

Control Logic

The μ PB8212 has four control inputs: \overline{DS}_1 , DS₂, MD and STB. These inputs are employed to control device selection, data latching, output buffer state and the service request flip-flop.

DS1, DS2 (Device Select)

These two inputs are employed for device selection. When \overline{DS}_1 is low and DS_2 is high $(\overline{DS}_1 \cdot DS_2)$ the device is selected. In the selected state the output buffer is enabled and the service request flip-flop (SR) is asynchronously set.

Service Request Flip-Flop (SR)

The (SR) flip-flop is employed to generate and control interrupts in microcomputer systems. It is asynchronously set by the $\overline{\text{CLR}}$ input (active low). When the (SR) flip-flop is set it is in the non-interrupting state.

The output (Q) of the (SR) flip-flop is connected to an inverting input of a "NOR" gate. The other input of the "NOR" gate is non-inverting and is connected to the device selection logic (\overline{DS}_1 · DS₂). The output of the "NOR" gate (\overline{INT}) is active low (interrupting state) for connection to active low input priority generating circuits.

MD (Mode)

This input is employed to control the state of the output buffer and to determine the source of the clock input (C) to the data latch.

When MD is in the output mode (high) the output buffers are enabled and the source of clock (C) to the data latch is from the device selection logic $\{\overline{DS}_1 \cdot DS_2\}$.

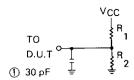
When MD is in the input mode (low) the output buffer state is determined by the device selection logic ($\overline{DS}_1 \cdot DS_2$) and the source of clock (C) to the data latch is the STB (Strobe) input.

STB (Strobe)

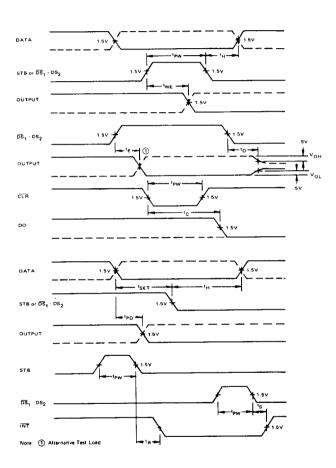
STB is employed as the clock (C) to the data latch for the input mode (MD = 0) and to synchronously reset the service request flip-flop (SR).

Note that the SR flip-flop triggers on the negative edge of STB which overrides CLR.

TIMING WAVEFORMS



Note: ① Including Jig and Probe Capacitance
TEST CIRCUIT



μPB8212

Package Outlines

For information, see Package Outline Section 7.

Plastic, μPB8212C Cerdip, μPB8212D